### APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL

Component Title: Capacitors, Microwave, Silicon, MOS, Naked Die based on Types 101M, 201M, 400M and 401M

Date: 23/06/2023

Appl. No.

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		1 5	xecutive Member	er.	CNES	•			Da	ite: 23/06/2023		286G	
Components (inclu	ding series and fami	lies) s	ubmitted for Ext	ensior	n of Qu	ıalificatio	n Approval	:					1
ESCC COMPONENT NO.	VARIANTS	RANGE OF COMPONENTS			Е	BASED ON		TEST VEHICLE / S		COMPONENT SIMILAR			
5711/002	11/002 01 to 31						400M			400M107A39M		other variants	
								20					
Component	Manufacturer	2	Location	of Ma	anufact	turing Pla	ant(s)	3					4
EXENS Solutions			3 avenue du Pacifique – Z.A. de Courtaboeuf 91940 Les Ulis Cedex France					Date:	Date of original qualification approval:  Date: 15/12/2008  Certificate Ref No. 286				
		Г						Т.					1-
ESCC Specification	ne used for	5	Deviations to	I V/T te	etina s	and Detai	il Specificat	6_ ion	Qualifi	cation Extension Repor	+		7
Maintenance of qua			used:	LVIIC	Jamiy C	and Detai	поресписа	1011	refere	nce and date:			
Generic: 5010	Issue: 3		No ⊠ '	Yes		(supply	details in E	Зох	20230220283-223 dated 07/02/2023				
Detail(s): 5711/0	002 Issue: 4		Deviation from current Specifications:										
			No ⊠ Yes □ (Supply details)										
			Maria 22 Maria	22			10 000						8
					alidity	period in	Support of to Date code		plication	(those to ESCC listed		arad	
Project Name Various	Testing Le	evel	LAT Chart F4B Various				Date code		Quantity Delivered				
PID changes since	start of qualification			9	Cun	rent PID	Verified by	<b>/</b> :		J.L Roux, CNE	S		10
None									Na	me of Excutive Represe	entative		
Minor* ⊠					Ref	No:	PID 302						
Trovido dotalio il ruoxi.				K			Date		01/06/2023				
	Editorial				Rev	Date:	01/06/202	23					- 44
Current Manufactur	ing facilities surveye	d by:	S. He	rnande	ez, ES	A and J.l	L. Roux, CN	IES	on	07	7/09/20:	22	11
			(Name of Executive Representative)				\$	(Date)					
Satisfactory:	Yes ⊠		No 🗆	Ex	plain								
Report Reference:	DTN/QE/E	C-202	22-0013332	_									
	294 22												

# APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL Page 2 Capacitors, Microwave, Silicon, MOS, Naked Die based on Types $101M,\,201M,\,400M$ and 401MComponent title: Appl. No. **Executive Member:** CNES Date: 23/06/2023 286G 12 Failure Analysis, DPA, NCCS available: Yes No (Supply data) Ref. No's and purposes: 2CEXE301 (Closed): Exceeding the authorized deadlines for the renewal of qualification 2CEXE302 (Open): NC on metallization see box 16 13 The undersigned hereby certifies on behalf of the ESCC Executive - that the above information is correct; that the appropriate documentation has been evaluated; - that full compliance to all ESCC requirements is evidence (except as stated in box 15;) - that the reports and data are available at the ESCC Executive and therefore applies on behalf of CNES as the responsible Executive Member for ESCC qualification status to be extended to the component(s) listed herein. Gianandrea Quadre Date: 19/06/2023 G. QUADRI, CNES (Signature of the Executive Coordinator) Continuation of Boxes above: 14 2 : Since January 2023 Cobham Microwave changed its name to become EXENS Solutions 3 : New adress since 2022 9 : Editorial changes related to the company transfer to a new site and to the new name (EXENS Solutions)

# ESCC

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Non compliance to E	SCC requireme	ents:					15
No.:	Specification	on		Paragraph		Non compliance	
1							
Additional tasks requi	rad to achieve f						
noncompliance:				qualification or rationale			16
The cause of the anor	maly (metal peel	ing) is like	ly due to oxyd	le surface pollution prior	to metallization. T	his affected a batch produced in 2012 on the	he old
implemented by Exen	s we propose no	t to delay	the renewal o	f qualification of the new	ot cause of the de production site.	flect. However, considering the corrective a	ctions
Executive Manager Dis	enosition						
Exceditive Manager Dis	sposition						17
Application Approval:	Yes 🛚 🗷	No					
Action / Remarks:							
						20	
ate:						J.K	
						B. Schade: Head of the Product Assurance	ce
						and Safety Department	

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ANNEX 1: LIST OF TESTS	DONE TO SUPPORT	<b>EXTENSION OF</b>	QUALIFICATION
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Tests conducted in compliance with:

ESCC 5010 generic specification; Chart V (for ESCC/QPL parts);
Or PID-TFD (for ESCC/QML parts)

Tests vehicle identification/description:

101M104A100M	400M106A100M
400M108C680M	

5711/002 Detail Specification reference:

Chart F4B	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
	Thermal Shock Test		ESCC 5010 Para. 9.5.2				Not required (naked die)
	Shock Test		MIL-STD-750 Test Method 2016				Not required (naked die)
Environmental/Mechanical Subgroups	Vibration Test		MIL-STD-750 Test Method 2056				Not required (naked die)
	Constant Acceleration		MIL-STD-750 Test Method 2006				Not required (naked die)
	Seal Test		MIL-STD-750 Test Method 1071				Not required (naked die)
	Moisture Resistance		MIL-STD-750 Test Method 1021				Not required (naked die)
	Seal Test		MIL-STD-750 Test Method 1071				Not required (naked die)
	Electrical Measurements at Room Temp.		Table 2 of the Detail Specification				Not required (naked die)
	External Visual Inspection		ESCC Basic Specification No. 20500				Not required (naked die)
Endurance Subgroup	Operating Life		MIL-STD-750 Test Method 1026	2242	15	0	
	Electrical Measurements during Endur. Test		Table 6 of the Detail Specification	2242	15	0	
	External Visual Inspection	$\boxtimes$	ESCC Basic Specification No. 20500	2242	15	0	



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Chart F4B	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
p – di	Electrical Measurements at Room Temp.		Table 2 of the Detail Specification				Not required (naked die)
Electrical Subgroup – Electrical Measurements	Electrical Measurements at High & Low Temp's		Table 3 of the Detail Specification				Not required (naked die)
	External Visual Inspection		ESCC Basic Specification No. 20500				Not required (naked die)
	Special Testing		The Detail Specification				Not required (naked die)
Electrical Subgroup  - Assembly Capability Tests	Solderability Test		MIL-STD-750 Test Method 2026				Not required (naked die)
	Permanence of Marking		ESCC Basic Specification No. 24800				Not required (naked die)
Elect Cap	Terminal Strength		MIL-STD-750 Test Method 2036				Not required (naked die)
De- encapsulation Sub group	Internal Visual Inspection	⊠	ESCC Basic Specification No. 20400	2242	4	0	
Capsu Sub gr	Bond Stregth	×	MIL-STD-750 Test Method 2037	2242	4	0	
enc	Die Shear	$\boxtimes$	MIL-STD-750 Test Method 2017	2242	4	0	



Box 22

Additional Comments.

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### NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL

ENTRIES	
Form heading	shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.
Box 2; 3 and 4	As per QPL entry; otherwise, an explanation of the changes must be supplied.
Box 5	Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.
Box 6	Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.
Box 7	Must reference the report(s) supplied in support of the application.
Box 8	Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.
Box 9	If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.
Box 11	This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.
Box 12	Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.
Box 13	Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.
Box 14	To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.
Box 15	Fill in Table as requested.
Box 16	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 17	All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.
Box 18	Fill in Table as requested.
Box 19	Confidential Details of PID changes including those of a confidential nature, shall be provided.
Box 20	State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.
Box 21	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.